# FAIRCHILD

SEMICONDUCTOR

# **FQT7P06 60V P-Channel MOSFET**

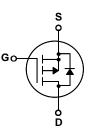
#### **General Description**

These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as automotive, DC/ DC converters, and high efficiency switching for power management in portable and battery operated products.

#### Features

- -1.6A, -60V,  $R_{DS(on)} = 0.41\Omega @V_{GS} = -10 V$  Low gate charge ( typical 6.3 nC)
- Low Crss (typical 25 pF)
- Fast switching
- Improved dv/dt capability
- SOT-223 FQT Series



## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQT7P06	Units
V <sub>DSS</sub>	Drain-Source Voltage		-60	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	(O°	-1.6	A
	- Continuous (T <sub>C</sub> = 70°	°C)	-1.28	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	-6.4	А
V <sub>GSS</sub>	Gate-Source Voltage		± 25	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	90	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	-1.6	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	0.21	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-7.0	V/ns
P <sub>D</sub>	Power Dissipation ( $T_C = 25^{\circ}C$ )		2.1	W
	- Derate above 25°C		0.017	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Rai	nge	-55 to +150	°C
TL	Maximum lead temperature for soldering 1/8" from case for 5 seconds	g purposes,	300	°C

### **Thermal Characteristics**

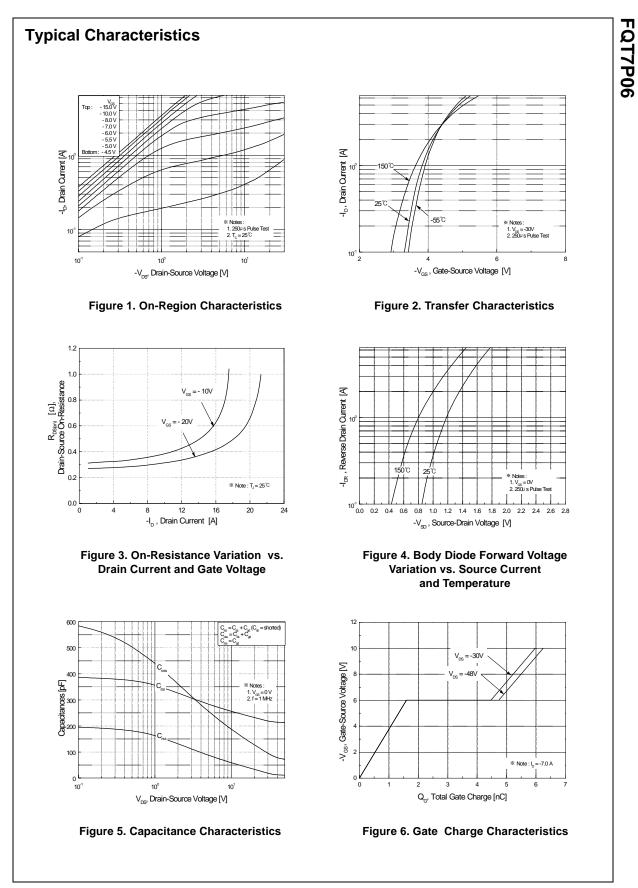
Symbol	Parameter	Тур	Max	Units
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient *		60	°C/W

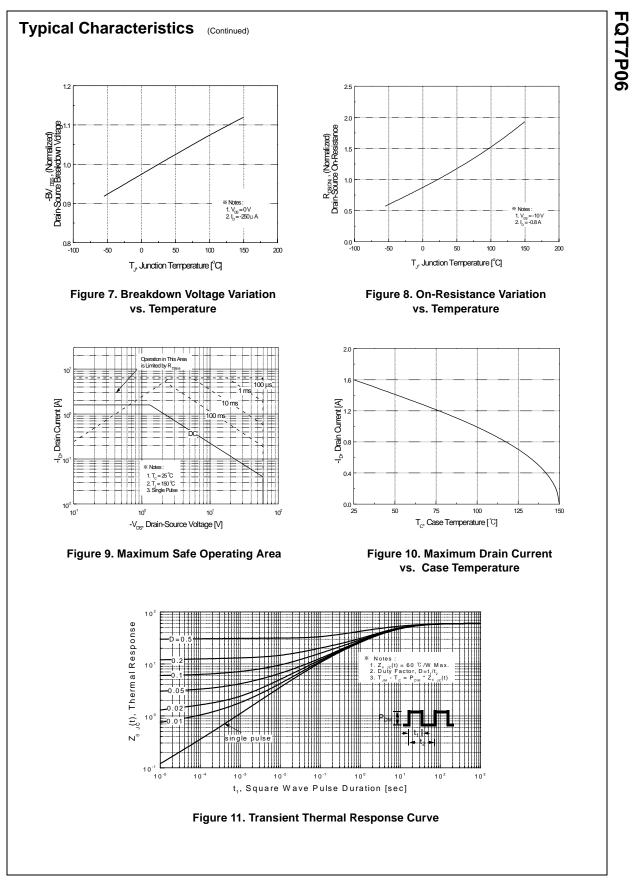
# QT7P06

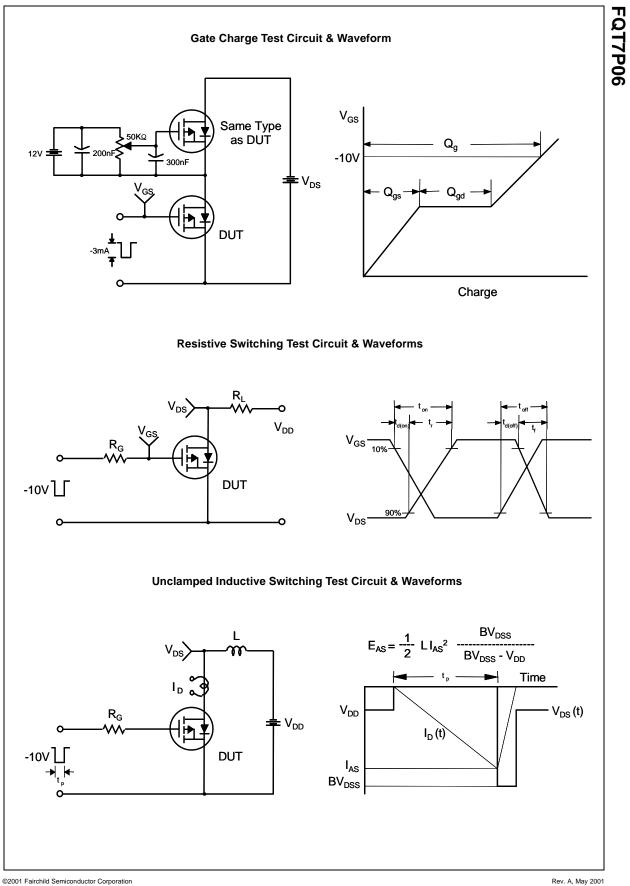
May 2001

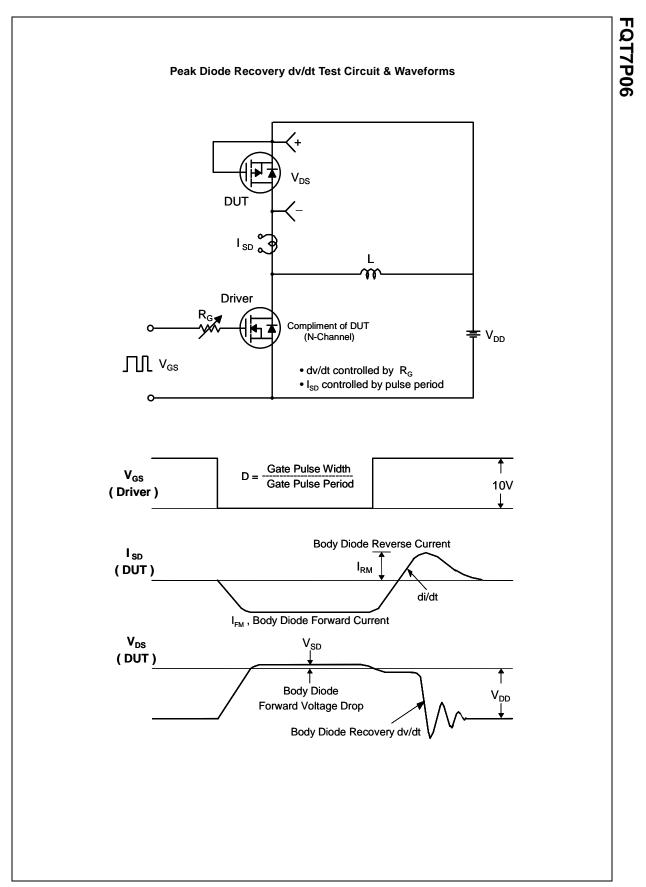
FET™

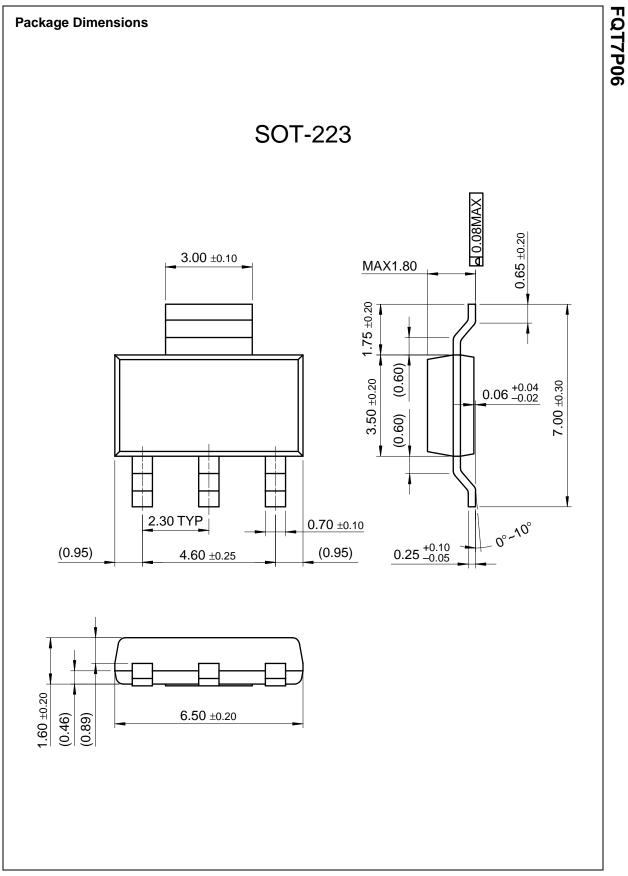
ymbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	racteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250 μA	-60			V
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu$ A, Referenced to 25°C		-0.07		V/°C
I <sub>DSS</sub>		V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V			-1	μA
	Zero Gate Voltage Drain Current	$V_{DS} = -48 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			-10	μA
GSSF	Gate-Body Leakage Current, Forward	$V_{GS} = -25 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
GSSR	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = 25 V, V <sub>DS</sub> = 0 V			100	nA
On Cha	racteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-3.0		-5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -0.8 A		0.32	0.41	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = -30 \text{ V}, I_D = -0.8 \text{ A}$ (Note 4)		2.4		S
<b>Dynam</b> i C <sub>iss</sub>	ic Characteristics			225	295	pF
C <sub>iss</sub> C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = -25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz		110	145	pF pF
C <sub>rss</sub>	Reverse Transfer Capacitance			25	32	pF
Switchi	ng Characteristics			7	25	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = -30 \text{ V}, \text{ I}_{D} = -7.0 \text{ A},$		50	110	ns
td(off)	Turn-Off Delay Time	$R_{G} = 25 \Omega$		7.5	25	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)		25	60	ns
Qg	Total Gate Charge	V <sub>DS</sub> = -48 V, I <sub>D</sub> = -7.0 A,		6.3	8.2	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -10 V$		1.6		nC
Q <sub>gd</sub>	Gate-Drain Charge	(Note 4, 5)		3.1		nC
Drain-S	ource Diode Characteristics an Maximum Continuous Drain-Source Dic				-1.6	A
l <sub>S</sub> Iou	Maximum Pulsed Drain-Source Diode F				-6.4	A
sм V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{S} = -1.6 \text{ A}$			-4.0	V
v SD rr	Reverse Recovery Time	$V_{GS} = 0 V, I_S = -7.0 A,$		77	-4.0	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_{\rm F} / dt = 100 \text{ A}/\mu \text{s}$ (Note 4)		0.23		μC
∝n	Reverse Receivery charge			0.20		μΟ
$\begin{array}{l} L=41mH,I_{\mu}\\ I_{SD}\leq~-7.0A,\\ Pulse~Test: \end{array}$	ating : Pulse width limited by maximum junction tempe $_{AS} = -1.6A$ , $V_{DD} = -25V$ , $R_G = 25 \Omega$ , Starting $T_J = 25^{\circ}C$ di/dt $\leq 300A/\mu_s$ , $V_{DD} \leq BV_{DSS}$ , Starting $T_J = 25^{\circ}C$ Pulse width $\leq 300\mu_s$ , Duty cycle $\leq 2\%$ dependent of operating temperature					











#### TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx <sup>TM</sup> Bottomless <sup>TM</sup> CoolFET <sup>TM</sup> CROSSVOLT <sup>TM</sup> DenseTrench <sup>TM</sup> DOME <sup>TM</sup> EcoSPARK <sup>TM</sup> $E^2$ CMOS <sup>TM</sup> EnSigna <sup>TM</sup> FACT <sup>TM</sup>	FAST <sup>®</sup> FASTr™ FRFET™ GlobalOptoisolator™ GTO™ HiSeC™ ISOPLANAR™ LittleFET™ MicroFET™ MICROWIRE™	OPTOPLANAR <sup>™</sup> PACMAN <sup>™</sup> POP <sup>™</sup> PowerTrench <sup>®</sup> QFET <sup>™</sup> QS <sup>™</sup> QT Optoelectronics <sup>™</sup> Quiet Series <sup>™</sup> SLIENT SWITCHER <sup>®</sup> SMART START <sup>™</sup>	SuperSOT <sup>™</sup> -3 SuperSOT <sup>™</sup> -6 SuperSOT <sup>™</sup> -8 SyncFET <sup>™</sup> TinyLogic <sup>™</sup> UHC <sup>™</sup> UHC <sup>™</sup> UltraFET <sup>®</sup> VCX <sup>™</sup>
FACT™ FACT Quiet Series™	MICROWIRE™ OPTOLOGIC™	SMART START™ Stealth™	

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

#### As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### **PRODUCT STATUS DEFINITIONS**

#### **Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

		L	
Fairchild Semiconductor		s <mark>SEARCH</mark>	Parametric   Cross Reference
		snace	Product Folders and Applica
find products	<u>Home</u> >> <u>Find products</u> >>		
Products groups	FQT7P06		Related Links
Analog and Mixed	60V P-Channel QFET		Request samples
<u>Signal</u>	Contents	Datasheet	Dotted line
Discrete	General description   Features   Product	Download this	How to order products
Interface	status/pricing/packaging	<u>datasheet</u>	Product Change Notices
<u>Logic</u> Microcontrollers		PDF	(PCNs)
Non-Volatile			Dotted line Support
Memory	General description	e-mail this datas	
Optoelectronics		[E-	Distributor and field sales
Markets and	These P-Channel enhancement mode power	( <u> </u>	representatives
applications	field effect transistors are produced using	This page	Dotted line Quality and reliability
New products	Fairchild's proprietary, planar stripe, DMOS	Print version	Dotted line
Product selection and parametric search	technology.		Design tools
Cross-reference	This advanced technology has been especially		
search	tailored to minimize on-state resistance,		
	provide superior switching performance, and		
technical information	withstand high energy pulse in the avalanche and commutation mode. These devices are well		
buy products	suited for low voltage applications such as		• •
technical support	automotive, DC/ DC converters, and high - efficiency switching for power management in	_	
my Fairchild	portable and battery operated products.		
company	-		
<u>_</u>	back to top		
	Features		

## back to top

Product status/pricing/packaging

• -1.6A, -60V

• Fast switching

o  $R_{DS(on)} = 0.41\Omega @V_{GS} = -10 V$ 

• Low gate charge (typical 6.3 nC)

• Low Crss (typical 25 pF)

• Improved dv/dt capability

Product	Product status	Pricing*	Package type	Leads	Packing method

FQT7P06TF	Full Production	\$0.342	SOT-223	3	TAPE REEL
* 1,000 piece Bu	dgetary Pricing				
1,000 piece Bu	ugetary i fieling				
back to top					
•					
Home   Eindones	du sta l Traducia si inform	otion   Door on	- decato I		
	<u>ducts   Technical inform</u> ny   Contact us   Site in				